

**Search Notes**

Application/Control No.

10/701,249

Examiner

Tuyen To

Applicant(s)/Patent under  
Reexamination

ICHIMIYA, JUNJI

Art Unit

2825

TT

**SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 716   | 10       | 2/17/2006 | TT       |
| 716   | 9,12-14  | 2/17/2006 | TT       |
| 716   | 11       | 2/17/2006 | TT       |
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**INTERFERENCE SEARCHED**

| Class   | Subclass | Date      | Examiner |
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| 716   | 9        | 2/17/2006 | TT       |
| 716   | 11       | 2/17/2006 | TT       |
| 716   | 12-14    | 2/17/2006 | TT       |
| Interference search.<br>See the attached search<br>printout |          | 2/17/2006 | TT       |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE      | EXMR |
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| East Search. Text Search.<br>IEEE and ACM search.<br>See the attached search printout. | 2/17/2006 | TT   |
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